

TEST / CALIBRATION REPORT

Type Test Report for MECO Moving Coil Meter

Testing as per IS 1248 : 1993 (Category II)



ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF COMMUNICATIONS & INFORMATION TECHNOLOGY, (STQC Dte.) Government of India

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MEMORANDUM

The Test/Calibration Report issued by **ERTL (W)** is a record of the measurements conducted on the products submitted to it for testing / calibration and the results thereof. Unless otherwise specified in the report, the results are applicable only to those products which have been tested / calibrated and do not apply to other products even though declared to be identical.

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- 3. The result reported in this report are valid only at the time of and under the stated conditions of the measurements.

ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF INFORMATION TECHNOLOGY (STQC Dte.)	REPORT NO. ERTL(W)/2002E&S	286
SUBJECT: TYPE TESTING OF MOVING COIL METER	DATE	PAGE	OF
	1 3 MAY 2003	1	9

1. SCOPE

- 1.1 Service Request No : ERTL(W) / 20022611 dated 31-Dec.-2002
- 1.1.1 Service Request finalised on
- : 31-Dec.-2002.
- 1.2
 Requested by (Name and address of organisation)
 : MECO INSTRUMENTS PVT LTD., 301, BHARAT INDUSTRIAL EASTATE, T.J. ROAD, SEWREE (W), MUMBAI – 400 015.

1.3	Description	Qty	Manufacturer	Model	Serial Nos.
	MOVING COIL METER, 0 – 500 VDC. CLASS - 1.5	03 Nos.	MECO	M 96	7609/2 - SAMPLE 1 (S-1) 1242/3 - SAMPLE 2 (S-2) 1243/3 - SAMPLE 3 (S-3)

1.4 Test specifications

1.5 Lab Ambient

1.6 Test Equipment used :

TYPE TEST AS PER IS 1248:1993, CATEGORY II

Temperature	:	(25 ±2) deg.C
Humidity	:	(55 <u>+</u> 5) % RH

1.	Calibration System	S&C/138
2.	D.M.M	E&S/120
3.	Digital Insulation Tester	E&S/121
4.	W/I Auto Tester	E&S/066
5.	Environmental Chamber	ENV/042
6.	Environmental Chamber	WK 1000-2
7.	High Voltage Supply	COM/111
8.	Vibration Machine	ENV/008
9.	Shock Test Machine	ENV/018



TO THE REAL OF THE	Released By	Rele					
	0.0% 0.6%	0.4 %	0.6%		400 V 500 V		
	0.8%	0.8%	0.8 %		300 V		
	1.0%	0.8%	0.4 %		200 V		
	0.4 %	0.4 %	0.6 %			.out	
Complied	5-6	2-6	1-0	remussion variation shall be 100% of class index	Lower temp. 10 deg. C, Upper temp. 3/ deg.C Intrinsic error checked at following equidistant	variation due to ambient	2.4.1
						to influencial quantities	
	-0.8%	-1.0 %	-1.2 %		A 000C	Variation due	74
	-0.6 %	-0.2 %	-0.4 %		400 V		
	-10%	-0.2%	-0.4%		300 V		
	-0.2 %	0.8%	-0.2 %		100 V 200 V		
Complied	S-3	S - 2	S - 1	Class index (1.5%)	At following equidistant points	Intrinsic Error	2.3
		ouserveu in case or any or the 3 samples	OUSCI VCU	UICARUUWIN IIASIIUVCI.	surviced togenici and toit wrapped on body.	TCSI	
Complied	shover	No breakdown or flashover	No bre	There shall not be any	AT 3 kV AC rms for 1 min. between terminals	High Voltage	2.2
	M ohm	M ohm	M ohm				
Complied	S-3	S-2 > 2000	S-1 > 2000	Not less than 5 M ohm	At 500 V DC for 1 min. between terminals shorted together and hody	Insulation Resistance	2.1
Remark		Observation		Requirement	Test Condition	Test/Parameter	Sr.No.
						2.0 Test Results	2.0 Tes
4	7	3 MAY 2003	1 3 MA				
OF	PAGE		DATE		SUBJECT : TYPE TESTING MOVING COIL METER	T : TYPE TESTING	SUBJEC
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			таснан		ELECTRONICS REGIONAL TEST LABORATORY (WEST)	CONICS REGIONAL	ELECT

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	98	OF 9		Remark	Complied					Complied					Complied			CONAL TER	CS GOVI. OF INN	11 31 . and	MISTRY OF	A Construction of the second s
	KEFUKI NU. EKIT(W)/ 2002E&S286	PAGE 3				%0	0.4%	0.2%	S-3		0 %					0.6%	0.4 %	0.6%	0.4%	0.6 %//3	Released By	
	NO. EKIL(W	cunc	CUU CUU	Observation		% 0	0% 7.0	0.4 % 0.4 %	S-2		% 0	<u> </u>				0.2 %	0 %	0.2 %	0.6%	0.4 %	Releas	
Tacaaa	KEPUKI	2 MAV 2003				0.2 %	0/ 0	0.2 %	S-1		0.2 %					0.4%	0.2 %	0.7%	0.6%	0.6 %		
				Kequirement	Permissible variation shall be 100% of class index				Permissible variation shall be	50% of class index					Permissible variation shall be 50% of class index							
ELECTRONICS REGIONAL TEST LABORATORY (WEST)	MINISTRY OF INFORMATION TECHNOLOGY (STQC Dtc.)	SUBJECT : TYPE TESTING MOVING COIL METER	÷ c	lest Condition	Lower Relative humidity 25%, Upper Relative humidity 80% Intrinsic error checked at following equidistant points	100 V	200 2	500 V 500 V	a) Apply DC excitation at 80 % of upper	· =	b) Superimpose 20 % of ripple at 45 Hz and increase to 65 Hz.	c) Note down the frequency for maximum	d) Channe the DC excitation to bring down	the value as at (a) above	Intrinsic error to be measured at reference plane and then at 5 deg. Inclination plane in forward, backward, left & right direction. Maximum deviation at following equidistant points		200 V	300 V	400 V	500 V		
ONICS REGIONAL	Y OF INFORMAT	T : TYPE TESTING	E	I est/Parameter	Variation due to humidity				Variation due	to ripple on	measured				Variation due to position				-			
ELECTR	MINISTF	SUBJEC		Sr.No.	2.4.2				2.4.3						2.4.4							

S REGIONAL	ELECTRONICS REGIONAL TEST LABORATORY (WEST)		REPORT	REPORT NO. ERTL(W) / 2002E&S286) / 2002F&S28	
	MINISTRY OF INFORMATION TECHNOLOGY (STQC Dtc.)					2
10	SUBJECT : TYPE TESTING MOVING COIL METER		I 3 MAY	Euu3	PAGE 4	OF 9
1						
	Test Condition	Requirement		Observation		Remark
Variation due to	AC excitation of upper limit under an external	6 % of fiducial value	S-1	S-2	S-3	Complied
	magnetic field of 0.4kA/m. Maximum deviation to be observed.		1.2 %	1.0 %	1.0 %	
Variation due to ferromagnetic supports	Accuracy test carried out by mounting UUT on Non Ferrous Panel (PVC) & Ferrous Panel at following equidistant points	Within the limit of intrinsic error				Complied
	100 V		0.4%	%0	% 0 % 0	
	300 V		0.2 %	%0	0%	
	400 V 500 V		% % 0	0 % 0.2 %	0.2 %	
Variation due to conductive sumorts	Accuracy test carried out by mounting UUT on conductive support following equidistant points	Shall meet the requirement of intrinsic error		-		Complied
			-0.2 %	0.6%	-0.2 %	****
	300 V		-0.8 %	-0.6%	-1.4 %	-
	400 V 500 V		-1.0 % -1.4 %	-0.8 % -1.4 %	-1.2 % -1.4 %	
	By suddenly applying $2/3^{rd}$ of measuring range & note down the % overshoot.	Shall not exceed 20% of scale length	16%	16 %	16 %	Complied
Response time	By suddenly applying $2/3^{rd}$ of measuring range & note down time (sec).	Within 1.5% scale length after 4 s.	Indices reached the po within 4s in each case	Indices reached the position of rest within 4s in each case	on of rest	Countied
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																					K	200	ATO	AY (W).	1.00	8	λ.
		OF 9	Remark	Complied		Complied							Complied								COMAL TERT	A served			9			
	1 2002E&S286	PAGE 5		S-3	0.6%	erved	S-3	0%	-0.8 %	0%0	-1.0%	-1.2 %	any of the			S-3	0.4 %	-0.6 %	0.6 %	-1.0%	-1.5 %		Deleased D	aseu D	TR		/	
	KEFUKI NU. EKIIL(W)/ 2002E85280	2003	Observation	S-2	0.4 %	No residual deflection observed	S-2	0.6%	0.2 %	-1.0%	-1.0%	-1.4 %	No deviation observed on any of the	pò		S-2	1.0%	0.4 %	-0.6 %	-0.6 %	-1.5 %		Dala	VCIC				
NTGOODD	NEPOKI N	DATE 3 MAY 2		S-1	0.4 %	No residual o	S-1	0.2 %	-0.2 %	-1.2 %	-1.0%	-1.4 %	No deviation	three samples		S-1	0.4%	-0.2 %	-1.0%	-1.0%	-1.5 %							
			Requirement	Shall comply with the	requirements of class index.	a) Residual deflection shall not exceed 1% of scale lenoth		b) Shall comply with the					a) Deviation of index from	zero scale mark shall not exceed 0 5% of scale lenoth		b) Shall comply with accuracy	requirements.		-				•					
ELECTRONICS REGIONAL TEST LABORATORY (WEST)	MINISTRY OF INFORMATION TECHNOLOGY (STQC Dte.)	SUBJECT : TYPE TESTING MOVING COIL METER	Test Condition	By applying 90% of upper limit of measuring	range for 30 to 35 min. & note down the deviation $(\%)$	a) By applying 120% of upper limit for 2h b) Accuracy test at following equidistant		100 V	200 V	300 V	400 V		a) Apply 1000 VDC for 0.5s nine times at an	interval of 60s and once for 5s.	b) Accuracy test at the following equidistant		100 V	200 V	300 V	400 V	500 V							
ONICS REGIONAL	Y OF INFORMATI	Γ : TYPE TESTING	Test/Parameter	Self Heating		Continuous overload				·			Overloads of	short duration														
ELECTR	MINISTR	SUBJEC	Sr.No.	2.6		2.7							2.8								1							

ELECTR	ONICS REGIONAL 7	ELECTRONICS REGIONAL TEST LABORATORY (WEST)			863-8 HCOOC / VI	
MINISTR	Y OF INFORMATIO	MINISTRY OF INFORMATION TECHNOLOGY (STQC Dtc.)		KEFUKI NU. EKILI V	A) / 2002E00228	D
UBJECT	T : TYPE TESTING N	SUBJECT : TYPE TESTING MOVING COIL METER		DATE	PAGE	OF
			-	3 MAY 2003	6	6
C.N.C	Tort/Docomptor	Tart Pandition	Davineet	C. P.		-here
2.9	Lesuraumeter Environmental Tests	1 CSI CONDITION	vedmianen	ODSELVATION	IIOI	Kemark
2.9.1	Temp. cycling	55 deg.C for 16h & -10 deg.C for 8h. 3 cycles while at 80% of the upper limit of excitation. During the last cycle at the end of 16h and while at high temp. slowly increase & decrease the excitation until index reaches the upper limit of measuring range & return to zero. Similarly after 8h at lower temp. slowly increase & decrease the excitation until index reaches the upper limit of measuring range & return to zero.	To be conditioned	Conditioned Indices were responding to excitation change.	nding to	
2.9.2	Post	At the following equidistant points :	-	S-1 S-2	S-3	Complied
	Measurement Intrinsic error			0.2% 0.8%		•
		300 V 400 V			% -1.4 %	
				-1.4 % -1.4 %		
2.9.3	Damp Heat	As per IS 9000. Part 5 Sec. 1 (16+8) h)	To be conditioned	Conditioned	med	

PAY (W) *:~ 6 F B MARTINE CONTINUE

-0.2 % -1.0 % -0.6 % Released By

0.6% 0.4% -0.2% -1.2%

Complied

-0.2 % 0.2 % -1.4 % -1.4 %

100 V 200 V 300 V 500 V

Measurement Intrinsic error

Post

2.9.4

S - 3

S-2

S - 1

Class index (1.5%)

As per IS 9000. Part 5 Sec. 1 (16+8) h) cycle. 2 cycles. Recovery 24 h. At the following equidistant points :

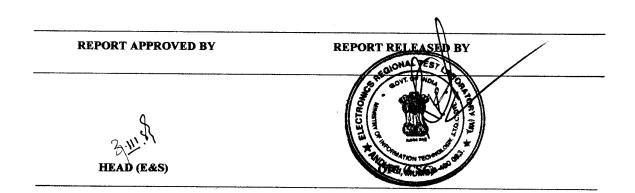
Damp Heat Cyclic Test

	······		I		DATA ORY (N) + +
86	9 GF		Complied		
REPORT NO. ERTL(W) / 2002E&S286	DATE PAGE AMAY 2003	Observation	No deviation observed in any of the three samples.	Conditioned No visual damage observed	Released By
	-	Requirement	Deviation expressed as percentage of scale length shall not exceed more than 50% of class index.	To be conditioned	
ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF INFORMATION TECHNOLOGY (STQC Dtc.)	SUBJECT : TYPE TESTING MOVING COIL METER	Test Condition	Energise the samples for 30s at upper limit of measuring range. Quickly reduce the excitation to zero. Deviation from zero shall be measured 15s after the excitation has been reduced to zero.	As per IS 9000 Part 8 Sweep range: 10-150-10 Hz Displacement amplitude: 0.15 mm peak in the range 10-60 Hz, Acceleration: 2g in the range: 60-150 Hz, Sweep Rate: 1 octave/min., Sweep Rate: 1 octave/min., Duration: 6 h. Endurance shall be performed at resonance frequency. Vibration shall be applied at the resonance frequency for 6h in that direction. If the resonance is observed in any of these 3 directions, the equipment shall be subjected to vibration at each of the frequencies 25, 50, 100 and 150 Hz in each of the 3 mutually perpendicular direction so that the total duration shall not exceed 6 h.	
NICS REGIONAL 7	: TYPE TESTING M	Test/Parameter	Deviation from zero	Vibration test	
ELECTRC MINISTR	SUBJECT	Sr.No.	2.10	2.11	

	9 9	Remark	Not	complied								Complied							Complied		ALL THE	and the second	el. " a DINE		(W).		and the second
002E&S286	PAGE (R	S-3			0.2 %	0.0%				-		0.2 %	0.2 %	0.2 %	0.2 %	0.7 %	·	S-3 Coi		0%0		-0.2 %				
REPORT NO. ERTL(W) / 2002E&S286	2003	Observation	S-2	0.6%	0.4 %	0.4%	0%0	Conditioned				S-2	0 %0	0.2 %	0.2 %	0.2%	0 %0	Conditioned	S-2	1.2 %	0.8%	-0.2 %	-0.2 %	-1.4 %	Released Bv		
REPORT NO	BATE 3 MAY 2		S-1	0	0.4 %	0.4%	0.0%				_				0.2 %	0.0%		-	S-1	0.4 %	0.4 %	-0.8 %	-0.4 %	-1.4 %			
		Requirement	Error shall not deviate more than					, To be conditioned							measured before shock test.			To be conditioned	Error shall be within class index								
ELECTRONICS REGIONAL LEST LABORATORY (WEST) MINISTRY OF INFORMATION TECHNOLOGY (STQC Die.)	SUBJECT : TYPE TESTING MOVING COIL METER	Test Condition	At the following equidistant points :		200 V	300 V 400 V	500 V		Pulse shape: half sine, Duration: 11 ms,	3 shocks in both directions of 3 mutually	perpendicular axes (total 18 snocks)	At the following equidistant points :		A 007	V 006	400 V 500 V		The UUI shall be subjected to 1,20,000 full scale deflections, the impulse supplied being of such amplitude that the pointer reaches max value of the scale without impinging on the end stop. ON for 1 sec OFF for 4 sec during one cycle.	At the following equidistant points :		200 2	300 V	400 V	500 V		و و و و و و و و و و و و و و و و و و و	
NICS REGIONAL 7	: TYPE TESTING N	Test/Parameter	Accuracy Test	(Post Vibration)				Shock Test			A	Accuracy 1 est	(NOOR SHOCK)				т <u>т</u> т. т.	LUIC 1 CSI	Accuracy Test	(Post Life Test)	-						
ELECTRC	SUBJECT	Sr.No.	2.12					2.13			11	7.14					21.0	C1.2	2.16								

ELECTRONICS REGIONAL TEST LABORATORY (WEST)	REPORT NO. ERTL(V	W)/2002E&	.S286
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3.0 General Remarks : NIL



OUR ACCREDITATION STATUS

ERTL (W) set up under the STQC Directorate, Ministry of Communications & Information Technology, Govt. of India has been accreditated under number of national / international systems as follows :

SYSTEM	AREA	STATUS
IECQ (International Electro-technical Commission on Quality Assessment System for Electronic Components)	 Component Testing Resistors (Fixed) Capacitors (Fixed) 	Accreditated as ITL (Independent Test Laboratory)
NABL (C), India National Accreditational Board for Test & Calibration laboratories (Calibration System)	Calibration • Electro-technical discipline • Thermal discipline • Mechanical discipline	Accreditated Calibration Laboratory
NABL(T), India National Accreditational Board for Test & Calibration laboratories (Testing System)	Electronic & Electrical Testing	Accreditated Test Laboratory
IECEE-CE-Scheme	 Mains Operated Electronic Consumer Products 	Approved as a CB test Laboratory
Other recognisation		Recognised by CSPO of State Govt., DOT, Naval Docyard, LCSO etc.